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Sun, 21 Dec 2008, 5:14:44 PM EST

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#1 ((generat <near> offload <near> data and protocol <near> stack and switch)<IN>metadata)

#2 ((generat <near> offload <near> data and protocol)<IN>metadata)

#3 ((generat <near> offload <near> data <near> structure)<IN>metadata)

#4 ((detect* <near> fail-over or failover and peripheral <near> device*)<IN>metadata)

#5 ((detect* <near> fail* <near> link* and offload)<IN>metadata)

#6 ((detect* <near> fail* <near> link*)<IN>metadata)

#7 ((shar* <near> common <near> path)<IN>metadata)

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